



DC FEE R&D @ LNF

G. Felici







- 1. A bit of background (what are LNF Electronic Workshop skills ?)
 - 1. The DC of the KLOE experiment
 - 2. The cylindrical GEM based Inner Tracker for the KLOE experiment
- 2. BaBar DC FEE Overview (The architecture of BaBar DC FEE is still valid ? Can we reuse (some sections of) DC BaBar FEE ?)
 - 1. DC numbers
 - 2. FEE block diagram
 - 3. Analog to Digital Boards (ADB)
 - 4. The ELEFANT chip
 - 5. Triggered data flow
 - 6. ReadOut Interface Board (ROIB) block diagram
 - 7. Data Input/Output Module (DIOM)
 - 8. DC Trigger

- 3. Cluster counting in helium based gas mixtures
 - 1. FADC and local derivative tecnique
 - 2. LNF measurements (1992)
 - 1. Primary ionization estimation
 - 2. Measurements results
- 4. The TARGET1 chip (Can be used for cluster counting in SuxB DC ?)
- 5. Radiation environment BaBar experience
- 6. DC Front-End Electronics @ LNF
- 7. Conclusions





KLOE DC & IT upgrade

SuperB LNF Electronic Service - KLOE experiment (I)



Perugia SuperB Workshop – June 09

SuperB-DC

Supere LNF Electronic Service - KLOE experiment (II)



SuperB-DC



LNF Electronic Service - KLOE experiment (IV)



SuperB-DC

SuperB









BaBar DC FEE

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DC numbers

- Cylindrical (\approx 1.6 m external diameter, \approx 2.75 m length)
- Hex-cells (≈ 1.2 cm (radial dir) x 1.7 cm (azimuthal dir)
- 10 superlayers (4 layer each) 4 axial 6 stereo
- 7104 cells
- He:Isobutane (80%/20%) gas mixture 22 i.p./cm per mip - 44 electrons (total ionization)
- Average charge per electron \approx 8 fC (20% collected in first 10 ns)





SuperB BaBar FEE – Block Diagram



Requirements

- Tracking (charged-particle momentum and event reconstruction)
- dE/dx (particle identification)

SuperB-DC

• Trigger (multi-charged-particle trigger for the BABAR detector)



SuperB BaBar FEE – Analog to Digital Board (ADB)





"DCAC" Commercial amplifier & calibration

"ELEFANT"

8 channel 6b TDC/ADC ASIC Buffers 32 15MHz samples/ch on L1A 4 events deep Generates untriggered waveforms @15MHz

TRIG_MUX FPGA Stretches untriggered waveforms

to 3.7MHz sampling and serializes 4 channels onto 1 output stream (15MHz).

SuperB-DC



SuperB BaBar FEE – ELEFANT block diagram

SuperB-DC







ADB ELEFANT 8 channels x 32 15MHz samples/ch x 8b / sample (8 x 15MHz) (8 x 15 MHz bus)

Sense wires



SuperB BaBar FEE – ReadOut Interface Board (ROIB) – block diagram



SuperB-DC



BaBar FEE – ReadOut Interface Board (ROIB)



ADB connectors

Spartan3 FPGA Decodes fast control cmds (L1A,RdEv,R/W cfg)

Reads data from 3 ADBs in parallel for triggered and untriggered data streams.

Applies feature extraction.

Remote Firmware Download FPGA PROM can be reprogrammed over G-Link



SuperB BaBar FEE – Data Input/Output Module (DIOM)



SuperB-DC

DATA INPUT/OUTPUT MODULE

1. Decode the READ EVENT and propagates it to FEAs

2. ELEFANT chips are readout into local FIFOs 3. After \approx 20 $\mu s\,$ (fixed delay) a GRANT signal is issued for each FEA

4. The FEA begins the synchronous data transfer from internal FIFOs to the G-link





BaBar FEE – DC Trigger

Chain

SuperB-DC

Trigger interface require hit information from every channel at a trigger rate of 3.7 MHz

 The ELEFANT presents on 8 output pins the status of readout buffer at a sample rate of 14.873 MHz

• Presence of TDC data in the sampling period or over-threshold signal from ADC data

• A dedicated FPGA in ADB board provide down samples ELEFANT trigger data output (by stretching and multiplexing) to 3.7 MHz and serialized on the ROIB on a 59.5 MHz line.

• 16 data channels are sent out on each 59.5 MHz trigger link to the Trigger Input/Output Module (TIOM).

• The TIOM multiplexes 20 links on a fiber that is sent to the trigger system







Cluster Counting







dE/dx using cluster counting [Walenta]

 \rightarrow Counting of primary ionization acts avoids Landau fluctuations in dE/dx measurements

 \rightarrow Possible in gas mixtures with low primary ionization and slow electron drift velocity

Cluster counting technique - FADC

- \rightarrow Fast preampifiers/shapers
- \rightarrow Fast digitization devices
 - → Flash ADCs [Grancagnolo et al]
 - Pros : high precision in reconstruction of charged particles dE/dx & low noise sensitivity
 - Cons : data amount (data processing required) & power dissipation (if integrated in the on-detector electronics section)

SuperB-DC Cluster Counting (II)

Cluster counting technique – Local derivative [G. Felici, G.

Bencivenni - LNF-92/036]

- \rightarrow Fast preampifiers/shapers
- \rightarrow Fast digitization devices
 - \rightarrow Local derivative method :
 - Pros : can be easily integrated in the on-detector electronics section & low power dissipation & no data processing required
 - Cons : accurate tuning required & noise sensitivity





Cluster Counting (III)

SuperB-DC

Primary ionization upper limit estimation







Measurement results

Average cluster size $\approx 1.5 \div 1.6$ electrons because of secondary ionization

Due to diffusion clusters blow-up while drifting toward sense wire \rightarrow electron separation time smaller than expected





SuperB-DC Subert TARGET1 (I)

16-channel, GSPS Transient Waveform Recorder with Self-Triggering and Fast, Selective Window Readout



Features

- → High density (16 channels)
- → Good timing performance
- → 9-10 bits of resolution
- → Fast conversion (<0.5us/32 samples)</p>
- → Random access to groups of 16 samples
- → Flexible operating modes
- → 100Ω, 1k and 10k programmable terminators.

Key Specifications

- Low power (<10mW/channel)</p>
- Giga-sample per second recording
- → Selective (windowed) readout
- → 4,096 storage samples/channel

Applications

- Next generation TeV gamma readout.
- Low-cost, highly integrated systems
- Collider Detector Instrumentation
- Portable/pocket oscilloscope







SELF

Servizio Elettronico Laboratori Frascati





Radiation Environment



- Radiation upset has been detected in FEE FPGA
- They found about 1 SEU/ROIB/hour
- Only 1/20 produce a functional upset
 - BaBar reconfigure the DCH electronics when any data integrity check fails ($\approx 2/day$)

Servizio Elettronico

Laboratori Frascati

SELF

 ■ Radiation damage was detected also in voltage regulators after ≈ 2 years exposure





LNF activity & Conclusions

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Front-End Electronics R&D (2009)

- Chamber prototype instrumentation (KLOE DC FEE)
- Cluster counting feasibility study
 - Iocal derivative method
 - oscilloscope acquisition
- RO architecture
 - BaBar "like"
 - Cluster counting option





• **Cluster counting** technique looks very interesting for dE/dx measurement, but can be difficult to manage \approx 10 kchs (power dissipation & system calibration)

Reuse of (sections) BaBar DC FE :

• BaBar experience discourage the use of commercial off-the-shelf (COTS) devices because radiation background (remote/local FPGA reprogramming is useful, but could not be enough for radiation tolerant design)

• Power dissipation and material budget must be also considered

• **BaBar DC FE architecture** worked well (as far as I know ...), so it could be successfully used for SuperB DC.